## Charge transport and magnetization profile at the interface between a correlated metal and an antiferromagnetic insulator

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A combination of spectroscopic probes was used to develop a detailed experimental description of the transport and magnetic properties of superlattices composed of the paramagnetic metal CaRuO<sub>3</sub> and the antiferromagnetic insulator CaMnO<sub>3</sub>. The charge carrier density and Ru valence state in the superlattices are not significantly different from those of bulk CaRuO<sub>3</sub>. The small charge transfer across the interface implied by these observations confirms predictions derived from density functional calculations. However, a ferromagnetic polarization due to canted Mn spins penetrates 3-4 unit cells into CaMnO<sub>3</sub>, far exceeding the corresponding predictions. The discrepancy may indicate the formation of magnetic polarons at the interface.

Recent advances in the atomic-scale control of transition metal oxide interfaces offer new opportunities for the manipulation of strongly correlated electron systems. While first device applications are being explored [1], there is growing awareness of the wealth of microscopic phenomena that need to be understood in order to arrive at a quantitative description of the electronic state at oxide interfaces. These include the polarity of the atomic layers comprising the interface [2], lattice relaxations (which are particularly important for ferroelectric and quantum paraelectric materials) [3], orbital reconstructions induced by misfit strain [4] and/or covalent bonding across the interface [5], magnetic polarization due to the reduced coordination of magnetic atoms and/or exchange interactions across the interface [6], and interface-specific disorder. This calls for simple model systems in which individual issues can be isolated, and the results of theoretical and experimental studies of buried interfaces can be quantitatively compared. A model system that has received particular recent attention is the weakly correlated metallic state at the interface between the band insulators SrTiO<sub>3</sub> and LaAlO<sub>3</sub>, whose properties are controlled by interface polarity and lattice relaxations although there is still an ongoing debate about the role of defects (see Ref. 7 and references therein).

Another problem of fundamental interest is the interface between a correlated metallic state and an antiferroagnetic insulator, two of the most extensively investigated ground states of bulk transition metal oxides. As theoretical research is beginning to address the length scales for the intermixing of metallicity and antiferromagnetic order in this situation [8, 9], the interface between the correlated paramagnetic metal CaRuO<sub>3</sub> (Refs. 10, 11, 12) and the antiferromagnetic insulator CaMnO<sub>3</sub> (Ref. 13) is emerging as a model system where these issues can be explored experimentally without interference from interface polarity, incipient ferroelectricity, extensive disorder or misfit strain, and orbital degeneracy. Whereas bulk CaMnO<sub>3</sub> is a *G*-type antiferromagnet (that is, the Mn spin orientation alternates along all nearest-neighbor bond di-

rections of the nearly cubic perovskite lattice), prior magnetometry [14] and magneto-optical [15] studies of CaRuO<sub>3</sub>-CaMnO<sub>3</sub> superlattices revealed a ferromagnetic moment centered at the interface. Based on density functional calculations, this was attributed to leakage of a small number of itinerant electrons from CaRuO<sub>3</sub> into the first atomic layer of CaMnO<sub>3</sub>, where they actuate a ferromagnetic double exchange interaction and induce canting of the Mn spins [8].

In this Letter we combine several spectroscopic probes of CaRuO<sub>3</sub>-CaMnO<sub>3</sub> superlattices including far-infrared (FIR) spectral ellipsometry, x-ray absorption spectroscopy (XAS), x-ray magnetic circular dichroism (XCMD), and x-ray resonant magnetic scattering (XRMS) in order to develop a comprehensive experimental description of the charge transport properties as well as the valence state and magnetic polarization of Ru and Mn atoms near the interface. We find that the charge transfer across the interface is small, and that the net magnetization of the superlattices arises mostly from canted Mn spins near the interface, confirming corresponding predictions of the density functional calculations [8]. Surprisingly, however, the penetration depth of the ferromagnetic polarization in CaMnO<sub>3</sub> is 3-4 unit cells (u.c.), greatly exceeding the theoretically predicted length scale of 1 u.c. Based on an analogy to lightly doped bulk CaMnO<sub>3</sub>, we attribute the large ferromagnetic penetration depth to polaronic effects not included in the calculations.

A series of superlattices, LaAlO $_3$  (001)/[CaMnO $_3$ (10 u.c.)/CaRuO $_3$ (N u.c.)] $_6$ , with N=4 to 10 consecutive CaRuO $_3$  unit cells were grown by pulsed laser deposition with a KrF excimer laser ( $\lambda=248$  nm, J=1 J/cm $^2$ ) at a substrate temperature of 720°C in 10 mTorr of pure oxygen, using stoichiometric sintered targets. Upon deposition, all samples were *in-situ* annealed in 50-100 mTorr of oxygen for 5-10 minutes, and then gradually cooled down to room temperature. Reflection high-energy electron diffraction (RHEED) oscillations observed *in situ* as well as spectroscopic data and XRMS profiles taken on the finished specimens demonstrate flat, atomi-

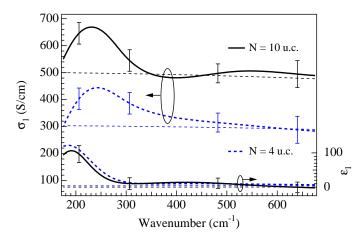


FIG. 1: Best-fit model functions  $\sigma_1(\omega)$  and  $\varepsilon_1(\omega)$  for superlattices with N=4 and 10 consecutive CaRuO<sub>3</sub> u.c., as obtained from FIR ellipsometry data by inversion of the ellipsometric parameters. The dashed lines represent the results of Drude fits, as described in the text. The peak at 220 cm<sup>-1</sup> superposed on the broad Drude response is due to a bond-bending lattice vibration of CaMnO<sub>3</sub>.

cally sharp interfaces. In agreement with prior work on this system [14, 15], magnetic susceptibility measurements on both samples indicate a net magnetization upon cooling below 120 K, coincident with the Néel temperature of bulk antiferromagnetic CaMnO<sub>3</sub>. The FIR experiments were conducted at beamline IR1 at the ANKA synchrotron in Karlsruhe, Germany, [16] with angles of incidence ranging from 70 to 85°. The XAS and XMCD measurements were performed at beamline 4-ID-C of the Advanced Photon Source, with magnetic fields of up to 7 T applied in the plane of the superlattices. The measurements were performed by monitoring the intensity, I, of left (-) and right (+) circularly polarized x-rays absorbed by the specimen using the surface/interface sensitive total-electron-yield detection described previously [5, 6]. The sum,  $I^++I^-$ , yields the XAS signal, while the XMCD signal is derived from the difference,  $I^+ - I^-$ . The XRMS experiments were carried out at the SIM beamline at the Swiss Light Source using the RESOXS chamber [17]. The reflected intensities  $I^+$  and  $I^-$  were collected for two opposite directions of a magnetic field applied along the intersection of the superlattice and scattering planes. The amplitude of the magnetic field available in the chamber is 0.16 T, which sufficient to field cool the sample into a partially magnetized state with a net magnetization of  $\sim$ 25% of the saturation value.

The charge transport properties of the CaRuO<sub>3</sub>-CaMnO<sub>3</sub> superlattices were determined by FIR ellipsometry, which yields the frequency-dependent complex dielectric function,  $\epsilon_1(\omega)+i\epsilon_2(\omega)$ , without the need for reference measurements and Kramers-Kronig transformations. In contrast to dc transport experiments, this method is insensitive to the influence of substrate-induced steps or strain-induced dislocations on the current flow through the atomically thin layers, and it avoids complications arising from the attachment of electrical contacts. Fig. 1 shows the real parts of the dielectric function,  $\epsilon_1(\omega)$ , and the optical conductivity,  $\sigma_1(\omega)=(1/4\pi)\omega\epsilon_2(\omega)$ ,

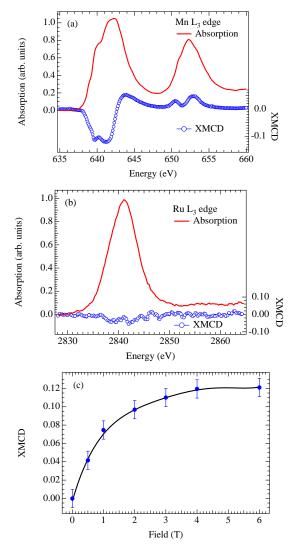


FIG. 2: (a) Absorption and XMCD measured at the Mn  $L_3$  edge at T=10~K for N=6. The XMCD of signal is sizable ( $\sim 12\%$ ) and consistent with rather large magnetic moment. (b) Absorption and XMCD from the Ru  $L_3$  edge for the 4 unit cell CaRuO $_3$  sample. Comparison with reference samples indicates that for both the Mn and Ru the valence is close to 4+. The very small apparent Ru XMCD signal is within the systematic error of the measurement.(c) Field dependence of the Mn XMCD measured at 10K showing that the magnetic moment saturates near 4T but shows not sign of remanent magnetization.

of the N=4 and 10 superlattices, which were extracted from the ellipsometric parameters measured at various angles of incidence using a nonlinear regression analysis [18]. Both data sets are well described by a broad Drude response with a ratio of scattering rate and plasma frequency  $\sim 0.2-0.3$ , which is typical for bulk single-crystalline CaRuO3 (dashed lines in Fig. 1). (Note that the parameters in the Drude fit are well constrained, because both  $\sigma_1$  and  $\epsilon_1$  are available. ) The effective number of charge carriers per Ru atom extracted from a sum-rule analysis,  $N_{\rm eff} = \frac{2m}{\pi e^2 n_{\rm Ru}} \int \sigma_1(\omega) d\omega = 0.11 \pm 0.03$  (where m is the free-electron mass and  $n_{\rm Ru}$  the density of Ru

atoms), is identical for both N=4 and 10 samples. It also agrees (within the measurement error) with the corresponding quantity  $N_{\rm eff}=0.082$  reported for bulk CaRuO<sub>3</sub> [10, 12]. These results indicate that even in the N=4 sample the conductivity of the metallic layers is not significantly disrupted by Ru-Mn interdiffusion, testifying to the high quality of the interfaces. They are also consistent with the theoretical prediction that only  $\sim 5\%$  of the charge carrier density in the CaRuO<sub>3</sub> atomic layer closest to the interface is transferred across the interface. A reduction of the Drude weight corresponding to a charge transfer of this magnitude is within the error of the FIR data.

XAS measurements near the Ru and Mn  $L_3$  absorption edges yield complementary information on the charge transfer across the interface. From a comparison of the absorption profiles (solid lines in Fig. 2) to reference compounds [19, 20, 21, 22, 23], we conclude that both Mn and Ru are close to the 4+ valence state. Specifically, in the N=4 sample (where half of the Ru atoms are at the interface) a substantial change in the Ru valence state due to charge transfer across the interface would result in a noticeable multiplet splitting of the Ru absorption peak due to population of  $e_g$  orbitals, similar to that seen in compounds containing Ru<sup>4+</sup>-Ru<sup>5+</sup> mixtures [21, 22, 23]. From the absence of this splitting in the data of Fig. 2b we infer an interfacial Ru valence close to 4+, consistent with the FIR data and with the predictions of Ref. 8.

The XMCD signals from the polarized XAS measurements yield information about the contribution of each constituent transition metal ion to the net magnetization (see Fig. 2). While the Ru XMCD does not exceed 3%, a clear XMCD signal of  $\sim 12\%$  is observed at the Mn L-edge for both samples in a magnetic field of 7 T and does not seem to depend on N, which is consistent with previous work[14]. Comparing with Ru XMCD references places an upper bound of  $\sim 0.3 \mu_B$  on the net magnetic moment per Ru atom while the Mn XMCD corresponds to an average moment of 1  $\mu_B$ per Mn atom[24], which implies that the net magnetization is dominated by CaMnO<sub>3</sub>, consistent with the theoretical work of Ref. 8. The Mn XMCD data also provide two pieces of evidence supporting the theoretically predicted canted antiferromagnetic state localized near the interface. First, the XMCD signal is substantially lower than expected if the layers were fully ferromagnetic[24], and it does not exhibit significant hysteresis effects. Second, the XMCD for both superlattices vanishes upon heating above 100-120 K, the Néel temperature of bulk CaMnO<sub>3</sub>, yet control measurements on an isolated CaMnO<sub>3</sub> film grown on SrTiO<sub>3</sub> (not shown) revealed no XMCD signal above background, which implies that the Mn magnetism is due to the CRO/CMO interface and not due to the entire CMO layer.

In order to determine the length scale of the interfaceinduced ferromagnetic polarization, we have performed XRMS measurements with circularly polarized x-rays at two photon energies in the vicinity of the Mn L<sub>3</sub> absorption edge. The resonant reflectivity in the charge channel  $(I^++I^-)$  exhibits a series of Bragg peaks characteristic of the superlattice periodicity, separated by interference fringes due the finite

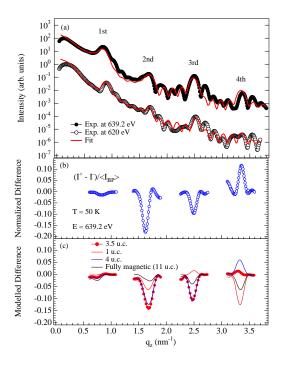


FIG. 3: (a) Specular reflectivity measured at room temperature with photon energy E=620 eV, below the Mn  $\rm L_3$  edge (upper trace) and at 50 K for E=639.2 eV on the Mn  $\rm L_3$  edge (lower trace). The lines are the results of fits to a structural model discussed in the text. The Bragg peak positions are indicated. (b) Dichroic differences  $I^+-I^-$  measured at the Bragg peak positions, normalized to the peak intensity. (c) Calculated normalized difference at the same Bragg peak positions for different layer thicknesses of the interface magnetized regions in CaMnO<sub>3</sub>

thickness of the sample (see Fig. 3(a)). The first photon energy (620 eV) was chosen off resonance allowing a structural analysis not relying on the knowledge of the resonant scattering factor (use of tabulated atomic scattering factor). The second one (639.2 eV, corresponding to the inflexion point of the edge) was chosen to reduce the x-ray absorption while maximizing the real part of the magnetic scattering factor [25, 26]. The analysis required knowledge of the structural parameters of the superlattices (thickness, roughness, and density of the layers) which were derived from a refinement of off-resonant reflectivity data recorded at 620 eV and confirmed by the refinement of the resonant reflectivity using the resonant scattering factor derived from the XAS measurements[27]. Although the fits exhibit some discrepancies with the data between the Bragg peaks, the relative intensities of the Bragg peaks and the widths of the intense ones are well described.

The magnetic profile is probed by the the charge-magnetic scattering in the  $I^+-I^-$  signal[25, 26]. Fig. 3(b) displays the difference  $I^+-I^-$  measured on top of the first four Bragg peaks normalized to the corresponding peak intensity (upper panel), as well as the results of simulations of this quantity for several models of the magnetic profile (see Fig. 3(c)). For the case of a superlattice, the key point is the  $q_z$  evolution due to the cross correlation of the charge and magnetic scattering in the XRMS signal. When the magnetic profile differs from the

chemical profile, the sign varies depending on the thickness of the magnetic layer within the charge layer (see Fig. 3(c)). By considering a simple symmetric step profile for the magnetization in CaMnO<sub>3</sub>, composed of equally thick magnetic layers at the interfaces and a non-magnetic core layer, we can study the evolution of the sign and gain insight into the thickness of the magnetic layer near the interface.

The simulated and observed intensities show very good agreement for an interfacial thickness of 1.38 nm (3.5 u.c.). This model reproduces both the experimentally observed sign sequence of  $I^+ - I^-$  at the Bragg peaks and its relative amplitude. The absolute magnitude of the normalized difference was calculated with the constraint that its integral equals the XMCD signal discussed above (scaled for the lower applied magnetic field, see Fig. 2c). As shown in Fig. 3(c), the result also agrees closely with the experimental data. Despite its simplicity, the model therefore provides an excellent description of the salient features of the XRMS data. From this we conclude that the ferromagnetic polarization is not limited to the immediate vicinity of the interface, as theoretically predicted [8], but extends further into the CMO layer. Specifically, a model in which the net magnetization arises entirely from the first CaMnO<sub>3</sub> unit cell at the interface is ruled out by the behavior of  $I^+ - I^-$  at the third- and fourth-order Bragg

Prior work on lightly La-doped bulk CaMnO<sub>3</sub> provides clues to the increased length-scale of the magnetic interface layer and the origin of the remarkably effective disruption of the antiferromagnetic order by a small density of electrons. Specifically, it was shown that this system exhibits a net magnetization of  $\sim 7\mu_B$  for each electron donated by La [13].

Based on transport [28] and neutron scattering measurements [29] as well as model calculations [30], this effect was attributed to the formation of a magnetization cloud extending over  $\sim 7$  Mn sites around the electron due to the ferromagnetic double exchange interaction it actuates between neighboring Mn spins, in conjunction with local lattice distortions. A closely related "orbital polaron" effect has also been investigated in lightly hole-doped manganates [31]. A similarly extended cloud of polarized Mn spins around electrons transferred across the CaRuO<sub>3</sub>-CaMnO<sub>3</sub> interface would explain the large ferromagnetic penetration depth we observed. Further work is required to assess whether the magnetic polarons form a narrow band, or whether they localize in a chargeordered state or in the vicinity of defects at the interface. In any case, our results suggest that magnetic polarons, which have been extensively investigated in bulk manganates and other transition metal oxides, strongly influence the physical properties of oxide interfaces and should therefore be considered in future theoretical work on this issue.

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